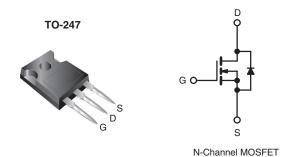


Power MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	200				
$R_{DS(on)}\left(\Omega\right)$	V _{GS} = 10 V	0.18			
Q _g (Max.) (nC)	70				
Q _{gs} (nC)	13				
Q _{gd} (nC)	39				
Configuration	Single				



FEATURES

- · Dynamic dV/dt Rating
- · Repetitive Avalanche Rated
- Isolated Central Mounting Hole
- Fast Switching
- · Ease of Paralleling
- · Simple Drive Requirements
- Lead (Pb)-free Available

Available RoHS* COMPLIANT

DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-247 package is preferred for commercial-industrial applications where higher power levels preclude the use of TO-220 devices. The TO-247 is similar but superior to the earlier TO-218 package because its isolated mounting hole. It also provides greater creepage distances between pins to meet the requirements of most safety specifications.

ORDERING INFORMATION	
Package	TO-247
Lead (Pb)-free	IRFP240PbF
	SiHFP240-E3
SnPb	IRFP240
	SiHFP240

PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V _{DS}	200	V	
Gate-Source Voltage			V_{GS}	± 20	V	
Continuous Drain Current	V _{GS} at 10 V	T _C = 25 °C T _C = 100 °C	l-	20	А	
		T _C = 100 °C	I _D	12		
Pulsed Drain Current ^a			I _{DM}	80		
Linear Derating Factor				1.2	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	510	mJ	
Repetitive Avalanche Current ^a			I _{AR}	20	Α	
Repetitive Avalanche Energy ^a			E _{AR}	15	mJ	
Maximum Power Dissipation	T _C = 25 °C		P _D	150	W	
Peak Diode Recovery dV/dt ^c			dV/dt	5.0	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 150	°C	
Soldering Recommendations (Peak Temperature)	for	for 10 s 300 ^d		300 ^d	7	
Mounting Torque	6 22 or l	C 00 av M0 aavav		10	lbf ⋅ in	
	6-32 or M3 screw			1.1	N · m	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. V_{DD} = 50 V, starting T_J = 25 °C, L = 1.9 mH, R_G = 25 Ω , I_{AS} = 20 A (see fig. 12).
- c. $I_{SD} \le 18$ A, $dI/dt \le 150$ A/ μ s, $V_{DD} \le V_{DS}$, $T_J \le 150$ °C.
- d. 1.6 mm from case.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply



THERMAL RESISTANCE RATINGS				
PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	R _{thJA}	-	40	
Case-to-Sink, Flat, Greased Surface	R _{thCS}	0.24	-	°C/W
Maximum Junction-to-Case (Drain)	R _{thJC}	-	0.83	

SPECIFICATIONS $T_J = 25$ °C,	unless otherv	vise noted					
PARAMETER	SYMBOL	TEST	MIN.	TYP.	MAX.	UNIT	
Static					<u>'</u>		,
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		200	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference t	o 25 °C, I _D = 1 mA	-	0.29	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V$	_{GS} , I _D = 250 μA	2.0	-	4.0	V
Gate-Source Leakage	I _{GSS}	V _G	V _{GS} = ± 20 V		-	± 100	nA
Zone Code Voltage Duein Comment		V _{DS} = 200 V, V _{GS} = 0 V		-	-	25	μΑ
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 160 V, V	V _{DS} = 160 V, V _{GS} = 0 V, T _J = 125 °C		-	250	
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 12 A ^b	-	-	0.18	Ω
Forward Transconductance	9 _{fs}	V _{DS} = 5	0 V, I _D = 12 A ^b	6.9	-	-	S
Dynamic							·
Input Capacitance	C _{iss}	$V_{GS} = 0 \text{ V},$ $V_{DS} = 25 \text{ V},$ f = 1.0 MHz, see fig. 5		-	1300	-	
Output Capacitance	C _{oss}			-	400	-	рF
Reverse Transfer Capacitance	C _{rss}			-	130	-	1
Total Gate Charge	Qg			-	-	70	nC
Gate-Source Charge	Q_{gs}	V _{GS} = 10 V	$I_D = 18 \text{ A}, V_{DS} = 160 \text{ V},$ see fig. 6 and 13^b	-	-	13	
Gate-Drain Charge	Q _{gd}		See lig. 6 and 13°	-	-	39	
Turn-On Delay Time	t _{d(on)}	V_{DD} = 100 V, I_{D} = 18 A, R_{G} = 9.1 Ω , R_{D} = 5.4 Ω , see fig. 10 ^b		-	14	-	- ns
Rise Time	t _r			-	51	-	
Turn-Off Delay Time	t _{d(off)}			-	45	-	
Fall Time	t _f			-	36	-	
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	5.0	-	- nH
Internal Source Inductance	L _S			-	13	-	
Drain-Source Body Diode Characteristic	s			I.			
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	20	- A
Pulsed Diode Forward Current ^a	I _{SM}			-	-	80	
Body Diode Voltage	V_{SD}	$T_J = 25 ^{\circ}\text{C}, I_S = 20 \text{A}, V_{GS} = 0 \text{V}^{\text{b}}$		-	-	2.0	V
Body Diode Reverse Recovery Time	t _{rr}	T 05.00 I			300	610	ns
Body Diode Reverse Recovery Charge	Q _{rr}	$T_J = 25 ^{\circ}\text{C}, I_F = 18 \text{A}, dI/dt = 100 \text{A}/\mu\text{s}^b$		-	3.4	7.1	μC
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L _S and				L _D)	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width $\leq 300~\mu s;$ duty cycle $\leq 2~\%.$



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

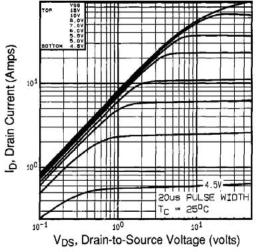


Fig. 1 - Typical Output Characteristics, $T_C = 25$ °C

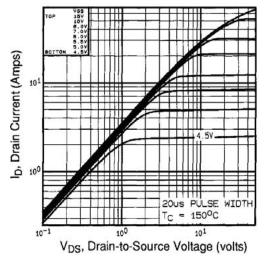


Fig. 2 - Typical Output Characteristics, $T_C = 150$ °C

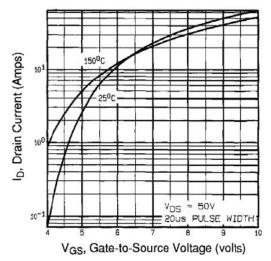


Fig. 3 - Typical Transfer Characteristics

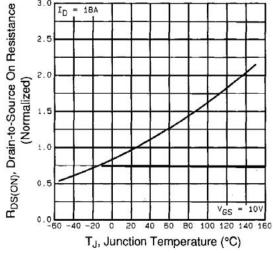


Fig. 4 - Normalized On-Resistance vs. Temperature



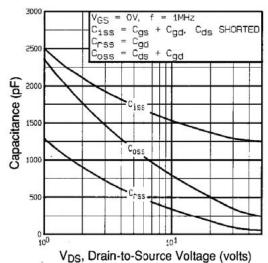


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

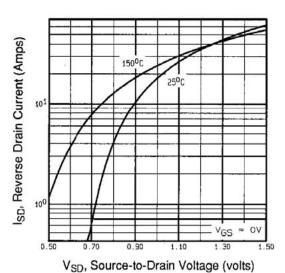


Fig. 7 - Typical Source-Drain Diode Forward Voltage

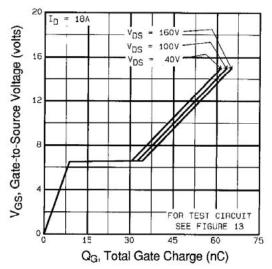


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

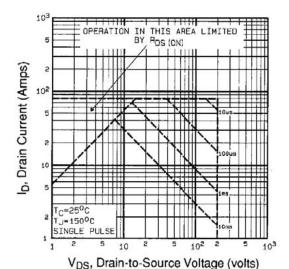
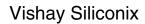


Fig. 8 - Maximum Safe Operating Area





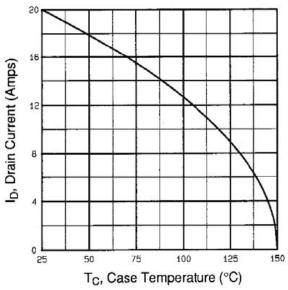


Fig. 9 - Maximum Drain Current vs. Case Temperature

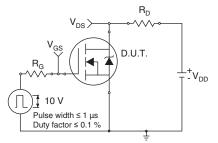


Fig. 10a - Switching Time Test Circuit

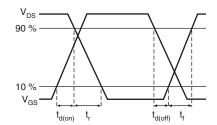


Fig. 10b - Switching Time Waveforms

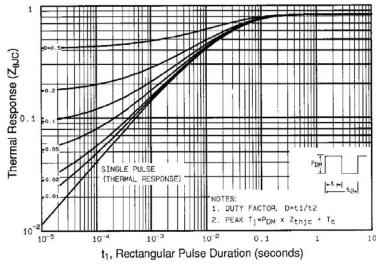


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



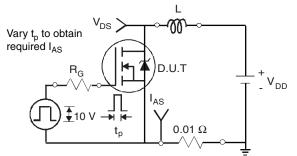


Fig. 12a - Unclamped Inductive Test Circuit

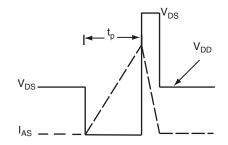


Fig. 12b - Unclamped Inductive Waveforms

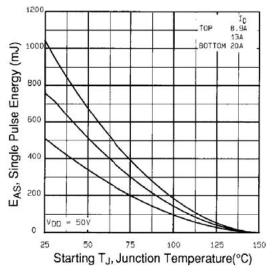


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

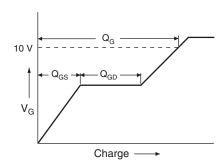


Fig. 13a - Basic Gate Charge Waveform

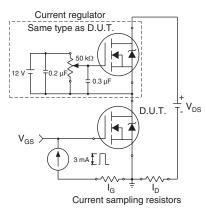
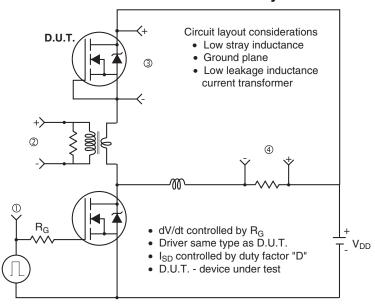
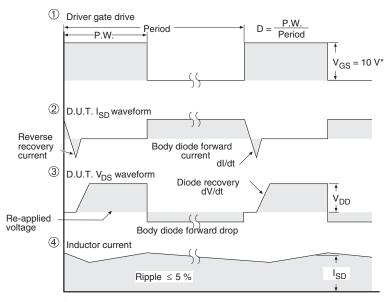


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit





* $V_{GS} = 5 V$ for logic level devices

Fig. 14 - For N-Channel

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